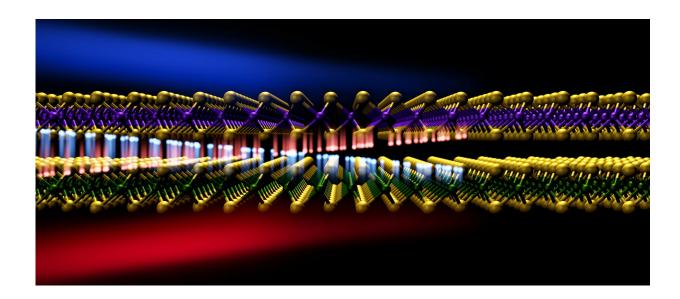


First direct view of an electron's short, speedy trip across a border

February 11 2019, by Glennda Chui



Electrons traveling between two layers of atomically thin material give off tiny bursts of electromagnetic waves in the terahertz spectral range. This glow, shown in red and blue, allowed researchers at SLAC and Stanford to observe and track the electrons' ultrafast movements. Credit: Greg Stewart/SLAC National Accelerator Laboratory

Electrons flowing across the boundary between two materials are the foundation of many key technologies, from flash memories to batteries and solar cells. Now researchers have directly observed and clocked these tiny cross-border movements for the first time, watching as electrons raced seven-tenths of a nanometer – about the width of seven



hydrogen atoms – in 100 millionths of a billionth of a second.

Led by scientists at the Department of Energy's SLAC National Accelerator Laboratory and Stanford University, the team made these observations by measuring tiny bursts of <u>electromagnetic waves</u> given off by the traveling electrons – a phenomenon described more than a century ago by Maxwell's equations, but only now applied to this important measurement.

"To make something useful, generally you need to put different materials together and transfer charge or heat or light between them," said Eric Yue Ma, a postdoctoral researcher in the laboratory of SLAC/Stanford Professor Tony Heinz and lead author of a report in *Science Advances*.

"This opens up a new way to measure how charge – in this case, electrons and holes – travels across the abrupt interface between two materials," he said. "It doesn't just apply to layered materials. For instance, it can also be used to look at electrons flowing between a solid surface and molecules that are attached to it, or even, in principle, between a liquid and a solid."

Too short, too fast – or were they?

The materials used in this experiment are <u>transition metal</u> <u>dichalcogenides</u>, or TMDCs – an emerging class of semiconducting materials that consist of layers just a few atoms thick. There's been an explosion of interest in TMDCs over the past few years as scientists explore their fundamental properties and potential uses in nanoelectronics and photonics.

When two types of TMDC are stacked in alternating layers, electrons can flow from one layer to the next in a controllable way that people



would like to harness for various applications.

But until now, researchers who wanted to observe and study that flow had only been able to do it indirectly, by probing the material before and after the electrons had moved. The distances involved were just too short, and the electron speeds too fast, for today's instruments to catch the flow of charge directly.

At least that's what they thought.

Maxwell leads the way

According to a famous set of equations named after physicist James Clerk Maxwell, pulses of current give off electromagnetic waves, which can vary from radio waves and microwaves to <u>visible light</u> and X-rays. In this case, the team realized that an electron's journey from one TMDC layer to another should generate blips of terahertz waves – which fall between microwaves and infrared light on the electromagnetic spectrum – and that those blips could be detected with today's state-of-the-art tools.

"People had probably thought of this before, but dismissed the idea because they thought there was no way you could measure the current from electrons traveling such a small distance in such a small amount of material," Ma said. "But if you do a back-of-the-envelope calculation, you see that if a current is really that fast you should be able to measure the emitted light, so we just tried."

Nudges from a laser

The researchers, all investigators with the Stanford Institute for Materials and Energy Sciences (SIMES) at SLAC, tested their idea on a



TMDC material made of molybdenum disulfide and tungsten disulfide.

Working with SLAC/Stanford Professor Aaron Lindenberg, Ma and fellow postdoc Burak Guzelturk hit the material with ultrashort pulses of optical laser light to get the electrons moving and recorded the terahertz waves they gave off with a technique called time-domain terahertz emission spectroscopy. Those measurements not only revealed how far and fast the <u>electric current</u> traveled between layers, Ma said, but also the direction it traveled in. When the same two materials were stacked in reverse order, the current flowed in exactly the same way but in the opposite direction.

"With the demonstration of this new technique, many exciting problems can now be addressed," said Heinz, who led the team's investigation. "For example, rotating one of the two crystal layers with respect to the other is known to dramatically change the electronic and optical properties of the combined layers. This method will allow us to directly follow the rapid motion of <u>electrons</u> from one <u>layer</u> to the other and see how this motion is affected by the relative positioning of the atoms."

More information: Eric Yue Ma et al. Recording interfacial currents on the subnanometer length and femtosecond time scale by terahertz emission, *Science Advances* (2019). DOI: 10.1126/sciadv.aau0073

Provided by SLAC National Accelerator Laboratory

Citation: First direct view of an electron's short, speedy trip across a border (2019, February 11) retrieved 23 April 2024 from

https://phys.org/news/2019-02-view-electron-short-speedy-border.html

This document is subject to copyright. Apart from any fair dealing for the purpose of private



study or research, no part may be reproduced without the written permission. The content is provided for information purposes only.